

S-89210/89220 Series

MINI ANALOG SERIES CMOS COMPARATOR

Rev.4.0_02

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The mini-analog series is a group of ICs that incorporate a general purpose analog circuit in a small package. The S-89210/89220 Series is a CMOS type comparator works on a lower voltage and lower current consumption. These features make this product the ideal solution for small battery-powered portable equipment. This product is a single comparator (with 1 circuit).

Features

- Lower operating voltage than the conventional general-purpose:
- Low current consumption:

 V_{DD} = 1.8 V to 5.5 V I_{DD} = 50 µA Typ. (S-89210 Series) I_{DD} = 10 µA Typ. (S-89220 Series) 4.0 mV Max.

- Low input offset voltage:
 Lead-free, halogen-free^{*1}
- *1. Refer to "
 Product Name Structure" for details.

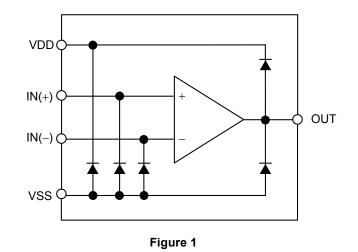
Application

- Mobile phones
- Notebook PCs
- Digital cameras
- Digital video cameras

Package

• SC-88A

Block Diagram

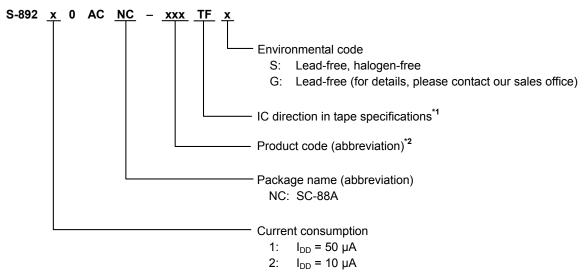


Rev.4.0_02

Product Name Structure

Users can select the product type for the S-89210/89220 Series. Refer to "1. **Product name**" regarding the contents of product name, "2. **Package**" regarding the package drawings and "3. **Product name list**" regarding the product type.

1. Product name



- ***1.** Refer to the tape specifications.
- *2. Refer to "3. Product name list".

2. Package

Deekeen Name		Drawing Code	
Package Name	Package	Таре	Reel
SC-88A	NP005-B-P-SD	NP005-B-C-SD	NP005-B-R-SD

3. Product name list

Table 1

Product name	Current consumption	Rise propagation delay time ^{*1}	Fall propagation delay time ^{*1}
S-89210ACNC-1C0TFz	50 μA	30 μs	6 μs
S-89220ACNC-1C1TFz	10 μA	150 μs	30 μs

*1. The value when V_{DD} = 3.0 V

Remark z: G or S

Pin Configuration



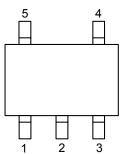


Table 2								
Pin No. Symbol Description								
1	IN(+) Non-inverted input pin							
2	VSS	GND pin						
3	IN(–)	Inverted input pin						
4	OUT Output pin							
5	5 VDD Positive power supply pir							

Figure 2

Absolute Maximum Ratings

Table 3

		(Ta = +25°C unless other	wise specified)
Parameter	Symbol	Absolute Maximum Ratings	Unit
Power supply voltage	V _{DD}	$V_{\text{SS}} - 0.3$ to $V_{\text{SS}} + 10.0$	V
Input voltage	V _{IN}	$V_{\text{SS}}-0.3$ to $V_{\text{SS}}+7.0$	V
Output voltage	V _{OUT}	$V_{\text{SS}} - 0.3$ to $V_{\text{DD}} + 0.3$	V
Differential input voltage	V _{IND}	±7.0	V
Output pin current	I _{SINK}	13	mA
Dewer dissinction	D	200 (When not mounted on board)	mW
Power dissipation	PD	350 ^{*1}	mW
Operating ambient temperature	T _{opr}	-40 to +85	°C
Storage temperature	T _{stg}	−55 to +125	°C

***1.** When mounted on board

[Mounted board]

(1) Board size: $114.3 \text{ mm} \times 76.2 \text{ mm} \times t1.6 \text{ mm}$

(2) Board name: JEDEC STANDARD51-7

Caution The absolute maximum ratings are rated values exceeding which the product could suffer physical damage. These values must therefore not be exceeded under any conditions.

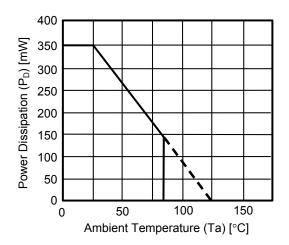


Figure 3 Power Dissipation of Package (When Mounted on Board)

Electrical Characteristics

		Table 4					
			(Ta =	= +25°C ι	unless of	therwise	specified)
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit	Test Circuit
Range of operating power supply voltage	V _{DD}	_	1.8	_	5.5	V	_

1. V_{DD} = 5.0 V

Table 5

DC Electrical Characteristic (V _{DD} = 5.0 V)			(Ta =	= +25°C ∣	unless of	herwise	specified)	
Parameter	Symbol	C	Conditions	Min.	Тур.	Max.	Unit	Test Circuit
Current concurrention		S-89210 Serie	S	-	50	120	μA	5
Current consumption	I _{DD}	S-89220 Serie	S	_	10	30	μA	5
Input offset voltage	V _{IO}		_	-4	±3	+4	mV	1
Input offset current	I _{IO}		_	-	1	-	pА	I
Input bias current	I _{BIAS}		_	-	1	-	pА	-
Common-mode input voltage range	V _{CMR}		_	0	-	4.3	V	2
Maximum output swing	V _{OH}	I _{OH} = 20 μA		4.7	1	-	V	3
voltage	V _{OL}	I _{OL} = 20 μA		-	1	0.01	V	4
Common-mode input signal rejection ratio	CMRR		_	60	70	_	dB	2
Power supply voltage rejection ratio	PSRR		_	60	70	_	dB	1
Source ourrept			S-89210 Series	120	-	_	μA	6
Source current	t I _{SOURCE} V _{OUT} = 0 V		S-89220 Series	25	1	_	μA	6
Sink current	I _{SINK}	V _{OUT} = 0.5 V		9	_	_	mA	7

Table 6

AC Electrical Characteristic	$(V_{DD} = 5.0)$) V)	(Ta =	: +25°C un	less othe	erwise sp	pecified)
Parameter	Symbol	Conditi	ons	Min.	Тур.	Max.	Unit
Disc propagation dalay time	+		S-89210 Series	_	45	_	μS
Rise propagation delay time	t _{PLH}		S-89220 Series	_	230	-	μS
Fall propagation dology time	+		S-89210 Series	_	9	-	μs
Fall propagation delay time	t _{PHL}	Overdrive = 100 mV	S-89220 Series	_	45	-	μs
Diag regrands time	+	C _L = 15 pF (Refer to Figure 11)	S-89210 Series	_	3	-	μs
Rise response time	t _{TLH}		S-89220 Series	_	15	-	μs
Fall reasonable time	+		S-89210 Series	_	3	-	μs
Fall response time	t _{THL}		S-89220 Series	-	15		μS

2. $V_{DD} = 3.0 V$

Table 7

DC Electrical Characteristic ($V_{DD} = 3.0$) V)		(Ta =	+25°C ι	unless of	herwise	specified)
Parameter	Symbol	C	Conditions	Min.	Тур.	Max.	Unit	Test Circuit
Current execution		S-89210 Serie	S	-	50	120	μA	5
Current consumption	I _{DD}	S-89220 Serie	S	_	10	30	μA	5
Input offset voltage	VIO		_	-4	±3	+4	mV	1
Input offset current	I _{IO}		_	_	1	-	pА	-
Input bias current	I _{BIAS}		_	_	1	-	pА	-
Common-mode input voltage range	V _{CMR}		_	0	-	2.3	V	2
Maximum output swing	V _{OH}	I _{OH} = 20 μA		2.7	-	_	V	3
voltage	V _{OL}	I _{OL} = 20 μA		_	_	0.01	V	4
Common-mode input signal rejection ratio	CMRR		_	60	70	_	dB	2
Power supply voltage rejection ratio	PSRR		_	60	70	_	dB	1
Source ourrept		· - • · ·	S-89210 Series	120	-	_	μA	6
Source current	ISOURCE	$V_{OUT} = 0 V$	S-89220 Series	25	-	_	μA	6
Sink current	I _{SINK}	V _{OUT} = 0.5 V		8	-	-	mA	7

Table 8

AC Electrical Characteristic	$(V_{DD} = 3.0)$) V)	(Ta =	+25°C un	less othe	erwise sp	becified)
Parameter	Symbol	Condit	ions	Min.	Тур.	Max.	Unit
Disc propagation dolay time	+		S-89210 Series	_	30	_	μS
Rise propagation delay time	t _{PLH}		S-89220 Series	_	150	_	μS
Fall propagation dolay time	1		S-89210 Series	_	6	_	μS
Fall propagation delay time	t _{PHL}	Overdrive = 100 mV	S-89220 Series	-	30	_	μS
		C _L = 15 pF (Refer to Figure 11)	S-89210 Series	-	2	_	μS
Rise response time	t _{TLH}	(Relet to rigure 11)	S-89220 Series	-	10	_	μS
			S-89210 Series	-	2	_	μS
Fall response time	t _{THL}		S-89220 Series	_	10	_	μS

3. V_{DD} = 1.8 V

Table 9

DC Electrical Characteristic	$(V_{DD} = 1.8)$	3 V)		(Ta =	+25°C ι	unless of	therwise	specified
Parameter	Symbol	C	Conditions	Min.	Тур.	Max.	Unit	Test Circuit
Current execution		S-89210 Serie	S	-	50	120	μA	5
Current consumption	I _{DD}	S-89220 Serie	S	_	10	30	μA	5
Input offset voltage	VIO		_	-4	±3	+4	mV	1
Input offset current	I _{IO}		_	_	1	_	pА	-
Input bias current	I _{BIAS}		_	_	1	_	pА	-
Common-mode input voltage range	V _{CMR}		_	0	-	1.1	V	2
Maximum output swing	V _{OH}	I _{OH} = 20 μA		1.5	-	_	V	3
voltage	V _{OL}	I _{OL} = 20 μA		_	-	0.01	V	4
Common-mode input signal rejection ratio	CMRR		_	60	70	_	dB	2
Power supply voltage rejection ratio	PSRR		_	60	70	_	dB	1
Source ourrent		<u> </u>	S-89210 Series	100	-	_	μA	6
Source current	I _{SOURCE} VOI	V _{OUT} = 0 V	S-89220 Series	20	-	_	μA	6
Sink current	I _{SINK}	V _{OUT} = 0.5 V		5	_	_	mA	7

Table 10

AC Electrical Characteristic	$(V_{DD} = 1.8)$	3 V)	(Ta = +	-25°C un	less othe	erwise sp	ecified)
Parameter	Symbol	Conditi	ons	Min.	Тур.	Max.	Unit
Disc propagation dalay time	+		S-89210 Series	_	20	-	μS
Rise propagation delay time	t _{PLH}		S-89220 Series	-	100	-	μS
Fall propagation dology time	1		S-89210 Series	-	5	-	μS
Fall propagation delay time	t _{PHL}	Overdrive = 100 mV	S-89220 Series	_	25	_	μS
Diag response time		C _L = 15 pF (Refer to Figure 11)	S-89210 Series	-	1.2	-	μS
Rise response time	t⊤LH	(Relef to Figure 11)	S-89220 Series	-	6	-	μS
			S-89210 Series	_	1.2	_	μS
Fall response time	t⊤н∟		S-89220 Series	_	6	_	μS

Test Circuit

1. Power supply voltage rejection ratio, input offset voltage

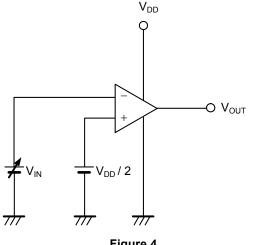


Figure 4

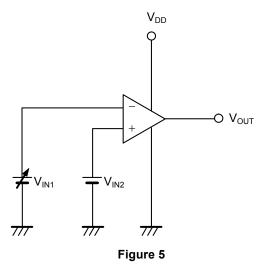
• Power supply voltage rejection ratio (PSRR) Input offset voltage (VIO)

The input offset voltage (V_{IO}) is defined as V_{IN} - V_{DD} / 2 when V_{OUT} is changed by changing V_{IN} to V_{DD} / 2 level. The power supply voltage rejection ratio (PSRR) can be calculated by following expression, with the value of V_{IO} measured at each V_{DD}.

Test conditions: When V_{DD} = 1.8 V: V_{DD} = V_{DD1} , V_{IO} = V_{IO1} When $V_{DD} = 5.0 \text{ V}$: $V_{DD} = V_{DD2}$, $V_{IO} = V_{IO2}$

$$\mathsf{PSRR} = 20 \log \left(\left| \frac{\mathsf{V}_{\mathsf{DD1}} - \mathsf{V}_{\mathsf{DD2}}}{\mathsf{V}_{\mathsf{I01}} - \mathsf{V}_{\mathsf{I02}}} \right| \right)$$

2. Common-mode input signal rejection ratio, common-mode input voltage range



Common-mode input signal rejection ratio (CMRR)

The common-mode input signal rejection ratio (CMRR) can be calculated by the following expression, with the offset voltage (V_{IO}) set as $V_{IN1} - V_{IN2}$ after V_{OUT} is changed by changing V_{IN1} .

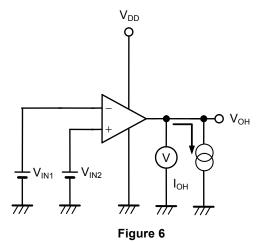
Test conditions: When $V_{IN2} = V_{CMR Max}$: $V_{IN2} = V_{INH}$, $V_{IO} = V_{IO1}$ When $V_{IN2} = V_{DD} / 2$: $V_{IN2} = V_{INL}$, $V_{IO} = V_{IO2}$

$$CMRR = 20 \log \left(\left| \frac{V_{INH} - V_{INL}}{V_{IO1} - V_{IO2}} \right| \right)$$

• Common-mode input voltage range (V_{CMR})

Varying V_{IN2} , the range of V_{IN2} that satisfies the common-mode input signal rejection ratio (CMRR) is the common-mode input voltage range (V_{CMR}).

3. Maximum output swing voltage (V_{OH})



• Maximum output swing voltage (V_{OH})

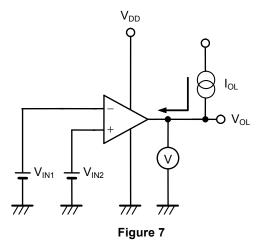
Test conditions:

$$V_{IN1} = \frac{V_{DD}}{2} - 0.5 V$$

$$V_{IN2} = \frac{V_{DD}}{2} + 0.5 V$$

$$I_{OH} = 20 \mu A$$

4. Maximum output swing voltage (V_{OL})



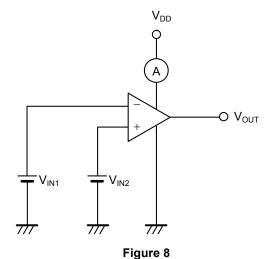
• Maximum output swing voltage (VoL)

Test conditions:

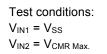
$$V_{IN1} = \frac{V_{DD}}{2} + 0.5 V$$

 $V_{IN2} = \frac{V_{DD}}{2} - 0.5 V$
 $I_{OL} = 20 \ \mu A$

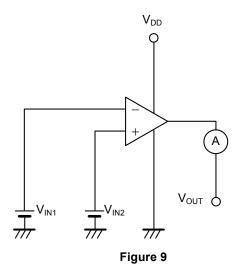
5. Current consumption



• Current consumption (IDD)



6. Source current



• Source current (ISOURCE)

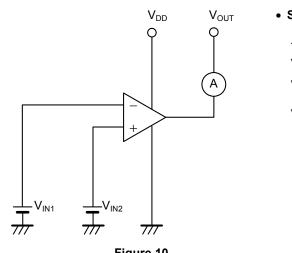
Test conditions:

$$V_{OUT} = 0 V$$

$$V_{IN1} = \frac{V_{DD}}{2} - 0.5 V$$

$$V_{IN2} = \frac{V_{DD}}{2} + 0.5 V$$

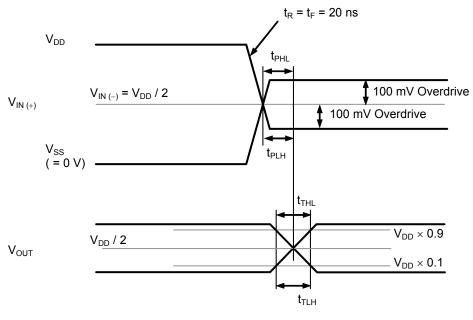
7. Sink current





- Sink current (I_{SINK})
 - Test conditions: $V_{OUT} = 0.5 V$ $V_{IN1} = \frac{V_{DD}}{2} + 0.5 V$ $V_{IN2} = \frac{V_{DD}}{2} - 0.5 \text{ V}$

8. Propagation time, response time





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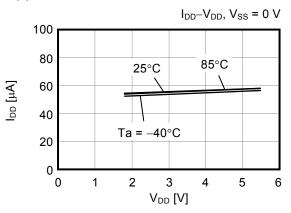
Precautions

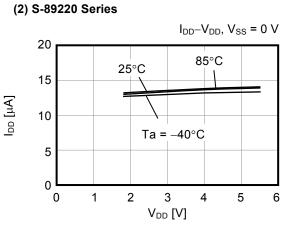
- Do not apply an electrostatic discharge to this IC that exceeds performance ratings of the built-in electrostatic protection circuit.
- ABLIC Inc. claims no responsibility for any disputes arising out of or in connection with any infringement by products including this IC of patents owned by a third party.
- Use this IC with the output pin current 13 mA or less.

Characteristics (Typical Data)

1. Current consumption (I_{DD}) vs. Power supply voltage (V_{DD})

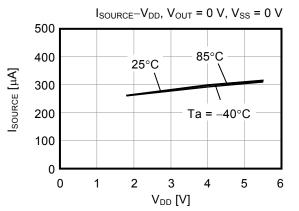
(1) S-89210 Series



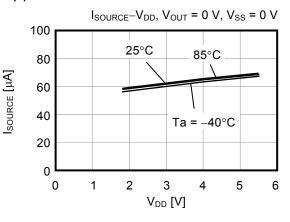


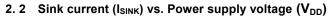
2. Output current characteristics

- 2.1 Source current (I_{SOURCE}) vs. Power supply voltage (V_{DD})
- (1) S-89210 Series

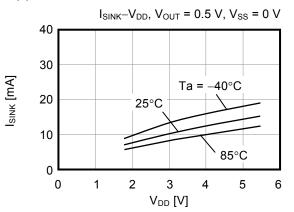


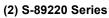
(2) S-89220 Series

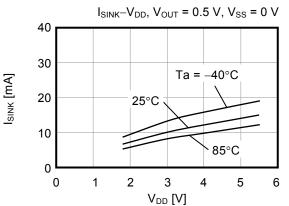


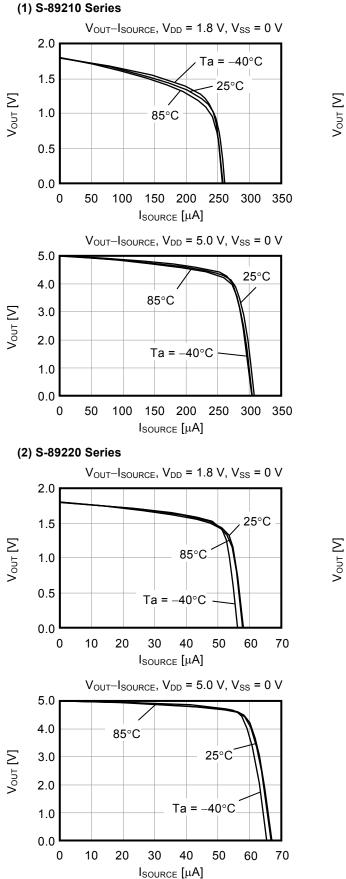


(1) S-89210 Series

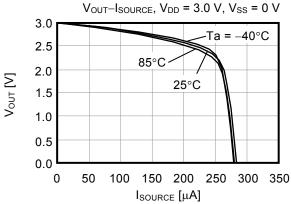


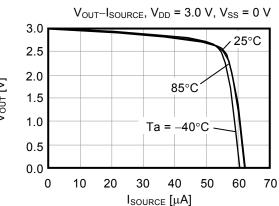






2. 3 Output voltage (V_{OUT}) vs. Source current (I_{SOURCE})





 $V_{OUT}-I_{SINK}$, V_{DD} = 3.0 V, V_{SS} = 0 V

`Ta = −40°C

40

30

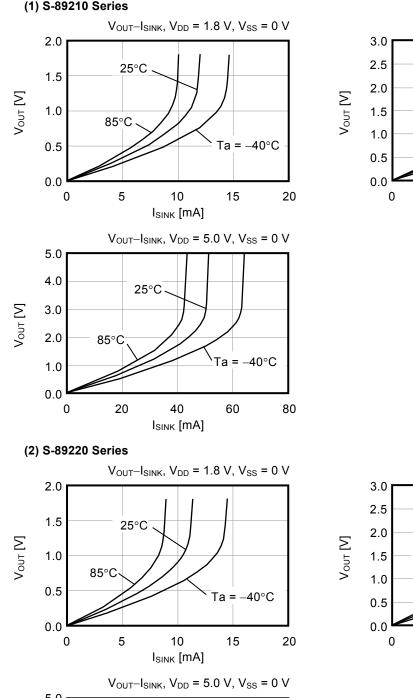
25°C

20

I_{SINK} [mA]

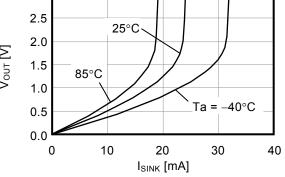
85°C

10

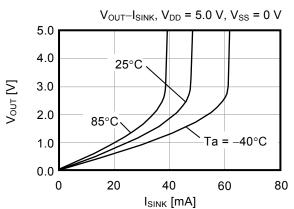


2. 4 Output voltage (VOUT) vs. Sink current (ISINK)

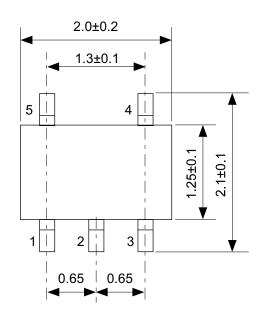
(1) S-89210 Series

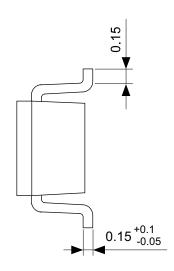


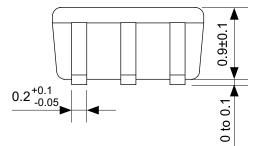
 $V_{OUT}-I_{SINK}$, V_{DD} = 3.0 V, V_{SS} = 0 V



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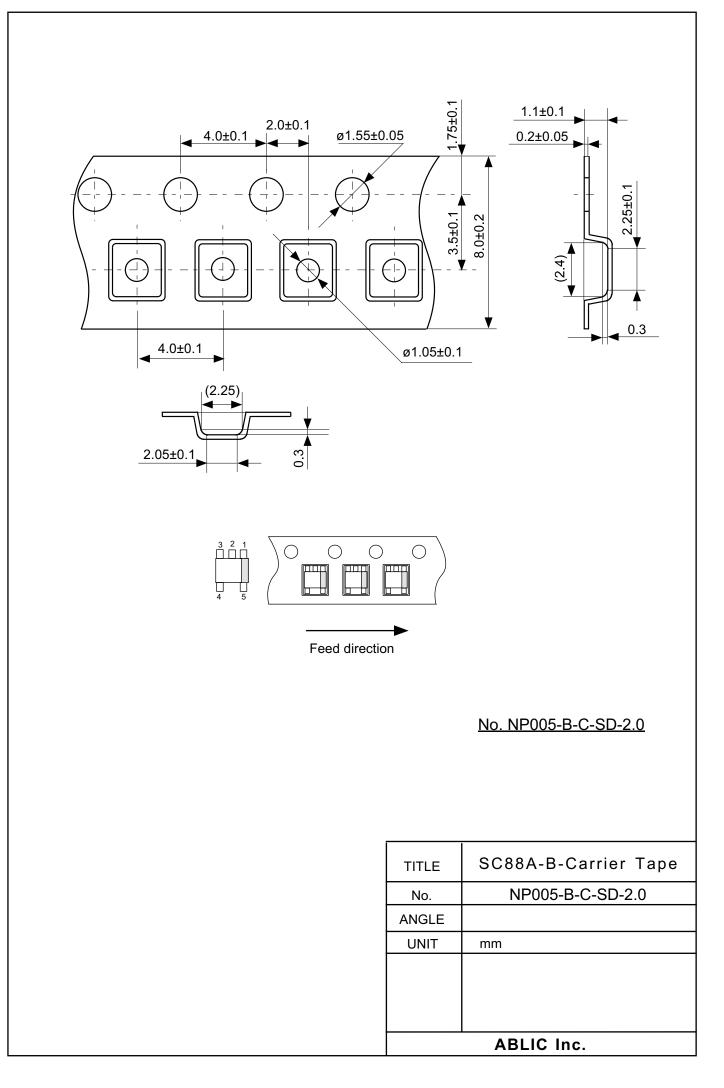


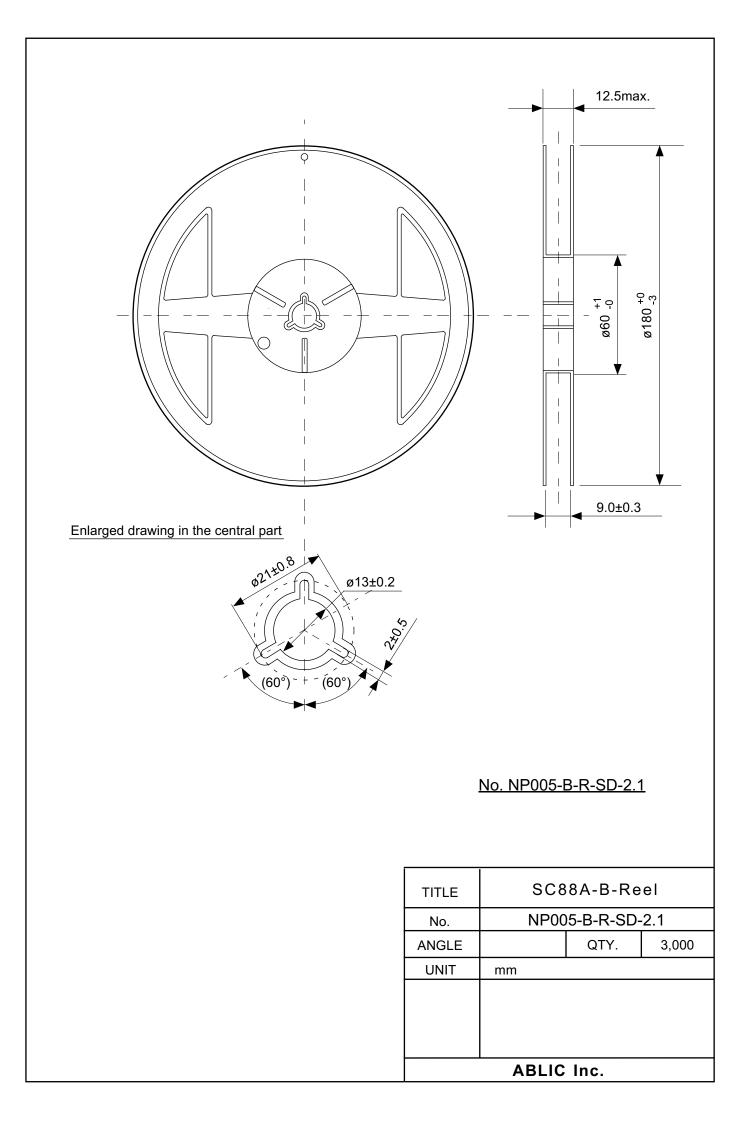




No. NP005-B-P-SD-1.2

TITLE	SC88A-B-PKG Dimensions				
No.	NP005-B-P-SD-1.2				
ANGLE	$\oplus \in \mathbb{R}^{+}$				
UNIT	mm				
	ABLIC Inc.				





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- 10. The products are not designed to be radiation-proof. The necessary radiation measures should be taken in the product design by the customer depending on the intended use.
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